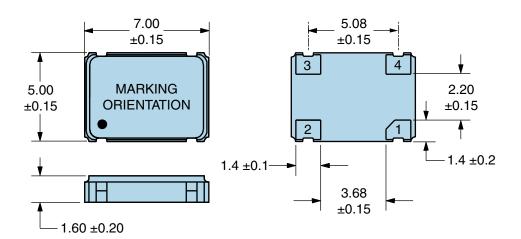


| ELECTRICAL SPECIFICATIONS             |   |  |
|---------------------------------------|---|--|
| Nominal Frequency                     | 37.056MHz   |  |
| Frequency Tolerance/Stability         | ±100ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) |  |
| Aging at 25°C                         | ±5ppm/year Maximum  |  |
| Operating Temperature Range           | 0°C to +70°C  |  |
| Supply Voltage                        | 3.3Vdc ±0.3Vdc  |  |
| Input Current                         | 35mA Maximum (No Load)  |  |
| Output Voltage Logic High (Voh)       | 2.7Vdc Minimum (IOH= -8mA)  |  |
| Output Voltage Logic Low (Vol)        | 0.5Vdc Maximum (IOH= +8mA)  |  |
| Rise/Fall Time                        | 6nSec Maximum (Measured at 20% to 80% of waveform)  |  |
| Duty Cycle                            | 50 ±5(%) (Measured at 50% of waveform)  |  |
| Load Drive Capability                 | 30pF Maximum  |  |
| Output Logic Type                     | CMOS  |  |
| Pin 1 Connection                      | Tri-State (High Impedance)  |  |
| Tri-State Input Voltage (Vih and Vil) | 70% of Vdd Minimum to enable output, 20% of Vdd Maximum to disable output, No Connect to enable output.   |  |
| Absolute Clock Jitter                 | ±250pSec Maximum, ±100pSec Typical  |  |
| One Sigma Clock Period Jitter         | ±50pSec Maximum, ±40pSec Typical  |  |
| Start Up Time                         | 10mSec Maximum  |  |
| Storage Temperature Range             | -55°C to +125°C   |  |

| ENVIRONMENTAL & MECHANICAL SPECIFICATIONS |   |  |
|---|---|--|
| ESD Susceptibility                        | MIL-STD-883, Method 3015, Class 1, HBM: 1500V |  |
| Fine Leak Test                            | MIL-STD-883, Method 1014, Condition A         |  |
| Flammability                              | UL94-V0                                       |  |
| Gross Leak Test                           | MIL-STD-883, Method 1014, Condition C         |  |
| Mechanical Shock                          | MIL-STD-883, Method 2002, Condition B         |  |
| Moisture Resistance                       | MIL-STD-883, Method 1004                      |  |
| Moisture Sensitivity                      | J-STD-020, MSL 1                              |  |
| Resistance to Soldering Heat              | MIL-STD-202, Method 210, Condition K          |  |
| Resistance to Solvents                    | MIL-STD-202, Method 215                       |  |
| Solderability                             | MIL-STD-883, Method 2003                      |  |
| Temperature Cycling                       | MIL-STD-883, Method 1010, Condition B         |  |
| Vibration                                 | MIL-STD-883, Method 2007, Condition A         |  |



### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN | CONNECTION                 |
|-----|----------------------------|
| 1   | Tri-State (High Impedance) |
| 2   | Ground                     |
| 3   | Output                     |
| 4   | Supply Voltage             |

| LINE | MARKING   |
|------|---|
| 1    | ECLIPTEK  |
| 2    | 37.056M   |
| 3    | PXXYZZ P=Configuration Designator XX=Ecliptek Manufacturing Code Y=Last Digit of the Year ZZ=Week of the Year |

#### **Suggested Solder Pad Layout**

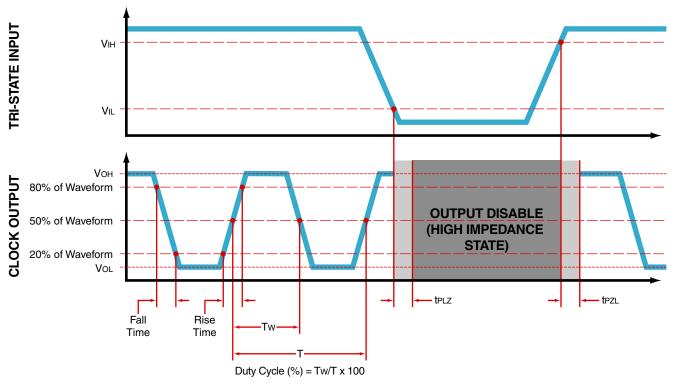
All Dimensions in Millimeters



All Tolerances are ±0.1



#### **OUTPUT WAVEFORM & TIMING DIAGRAM**



#### **Test Circuit for CMOS Output**



Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

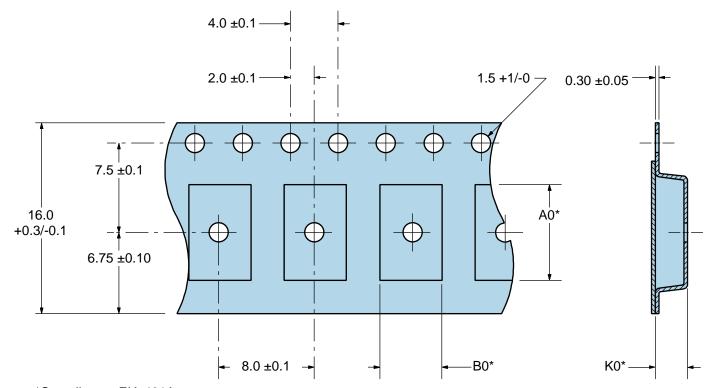
Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_L$  includes sum of all probe and fixture capacitance.

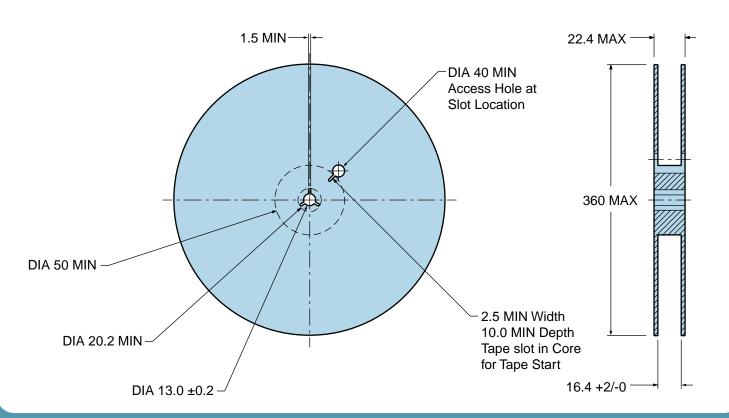


# **Tape & Reel Dimensions**

Quantity Per Reel: 1,000 Units



\*Compliant to EIA 481A





# **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

| 3°C/second Maximum                                |
|---|
|   |
| 150°C   |
| 175°C   |
| 200°C   |
| 60 - 180 Seconds                                  |
| 3°C/second Maximum                                |
|   |
| 217°C   |
| 60 - 150 Seconds                                  |
| 260°C Maximum for 10 Seconds Maximum              |
| 250°C +0/-5°C                                     |
| 20 - 40 seconds                                   |
| 6°C/second Maximum                                |
| 8 minutes Maximum                                 |
| Level 1   |
| Temperatures shown are applied to body of device. |
|   |



## **Recommended Solder Reflow Methods**



#### Low Temperature Infrared/Convection 240°C

| T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                     |
|---|--|
| Preheat   |  |
| - Temperature Minimum (T <sub>s</sub> MIN)          | N/A  |
| - Temperature Typical (T <sub>S</sub> TYP)          | 150°C  |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A  |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                       |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum                                     |
| Time Maintained Above:                              |  |
| - Temperature (T∟)                                  | 150°C  |
| - Time (t∟)   | 200 Seconds Maximum                                    |
| Peak Temperature (T <sub>P</sub> )                  | 240°C Maximum  |
| Target Peak Temperature (T <sub>P</sub> Target)     | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| Time within 5°C of actual peak (tp)                 | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                      | 5°C/second Maximum                                     |
| Time 25°C to Peak Temperature (t)                   | N/A  |
| Moisture Sensitivity Level                          | Level 1  |
| Additional Notes                                    | Temperatures shown are applied to body of device.      |

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)